

Notice of References Cited

Application/Control No.

10/802,043

Applicant(s)/Patent Under
Reexamination
SIE ET AL.

Examiner

Ryan Stronczer

Art Unit

4157

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,856,849 A	01-1999	Aihara, Kenichi	348/445
*	B	US-5,880,792 A	03-1999	Ward et al.	348/722
*	C	US-6,115,072 A	09-2000	Vuong et al.	348/445
*	D	US-2001/0024239 A1	09-2001	Feder et al.	348/423.1
*	E	US-2002/0053075 A1	05-2002	Paz et al.	725/10
*	F	US-2003/0025832 A1	02-2003	Swart et al.	348/461
*	G	US-6,714,253 B2	03-2004	Kim et al.	348/556
*	H	US-6,804,827 B1	10-2004	Furukawa et al.	725/140
*	I	US-7,234,003 B2	06-2007	Zaumen et al.	709/250
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.